Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/786,585	KANG ET AL.	
Examiner	Art Unit	
SIMON D. NGUYEN	2685	

	SEAR	CHED	
Class	Subclass	Date	Examiner
455	572-574	3/20/2006	SDN
	343.1-		
	343.4		-

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEAF (INCLUDING S	RCH NOTES SEARCH STRATEG	iY)
	DATE	EXMR
EAST	3/20/2006	SDN
		